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Application/Control No.	Applicant(s)/Patent under Reexamination
10/049,844	EVANS ET AL.
Examiner	Art Unit
Laurel Leebleu	2122

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST see Search History Printout	12/16/2005	LLL	
PLUS Search see Search History Printout	12/16/2005	LLL	
STIC Search Report see Search History Printout	7/20/2005	LLL	